### **Specifications**

| Drawing No.  | UKY1C-H1-17102-00[40] 1/9 |
|--------------|---------------------------|
| Issued Date. | Feb. 1,2017               |

| TO: Mouser |
|------------|
|            |

Note: In case of specification change, KYOCERA Part Number also will be changed.

|                               | -                    |
|-------------------------------|----------------------|
| Product Name                  | Quartz Crystal       |
| Product Model                 | CX5032GA             |
| Frequency                     | 12000kHz             |
| Customer Part Number          | -                    |
| Customer Specification Number | -                    |
| KYOCERA Part Number           | CX5032GA12000P0HFSZ1 |
| Remarks RoHS Compliant, MSL 1 |                      |
| AEC-Q200 Compliant            |                      |

#### **Customer Acceptance**

| Accept Signature | Approved Date    |  |
|------------------|------------------|--|
|                  | Department       |  |
|                  | Person in charge |  |

# Seller KYOCERA Crystal Device Corporation

(Sales Division)

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KYOCERA Crystal Device Corporation

Crystal Units Division

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| Design Department   | Quality Assurance | Approved by | Examination by | Issued by   |
|---|-------------------|-------------|----------------|-------------|
| KYOCERA Crystal Device Corporation<br>Crystal Units Engineering Section<br>Crystal Units Division | W.Muraoka         | H. Shoji    | A.lto          | M.Hashimoto |

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## **Revision History**

| Rev.No. | Description of revise | Date        | Approved by | Examination by | Issued by   |
|---------|-----------------------|-------------|-------------|----------------|-------------|
| 1       | First Edition         | Feb. 1,2017 | H. Shoji    | A.Ito          | M.Hashimoto |
|         |                       |             |             |                |             |
|         |                       |             |             |                |             |
|         |                       |             |             |                |             |
|         |                       |             |             |                |             |
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#### 1. APPLICATION

This specification sheet is applied to quartz crystal "CX5032GA12000P0HFSZ1"

#### 2. KYOCERA PART NUMBER

CX5032GA12000P0HFSZ1

#### 3. RATINGS

| Items                     | SYMB. | Rating      | Unit | Remarks |
|---------------------------|-------|-------------|------|---------|
| Operating Temperature     | Topr  | -20 to +70  | °C   |         |
| Storage Temperature Range | Tstg  | -40 to +150 | °C   |         |

## 4. CHARACTERISTICS ELECTRICAL CHARACTERISTICS

| Items             |                  | Elect | Electrical Specification |       |      | Test Condition       | Remarks |
|-------------------|------------------|-------|--------------------------|-------|------|----------------------|---------|
|                   | SYMB.            | Min.  | Тур.                     | Max.  | Unit |                      |         |
| Mode of Vibration |                  |       | Fundament                | al    |      |                      |         |
| Nominal           | F0               |       | 12                       |       | MHz  |                      |         |
| Frequency         |                  |       |                          |       |      |                      |         |
| Nominal           | T <sub>NOM</sub> |       | +25                      |       | °C   |                      |         |
| Temperature       |                  |       |                          |       |      |                      |         |
| Load Capacitance  | CL               |       | 18.0                     |       | pF   |                      |         |
| Frequency         | df/F             | -20.0 |                          | +20.0 |      | +25±3°C              |         |
| Tolerance         |                  |       |                          |       |      |                      |         |
| Frequency         | df/F             | -50.0 |                          | +50.0 |      | -20 to +70°C         |         |
| Temperature       |                  |       |                          |       | PPM  |                      |         |
| Characteristics   |                  |       |                          |       |      |                      |         |
| Frequency Aging   |                  | -5.0  |                          | +5.0  |      | 1 <sup>st</sup> year | +25±3°C |
| Rate              |                  |       |                          |       |      |                      |         |
| Equivalent Series | ESR              |       |                          | 150   | Ω    |                      |         |
| Resistance        |                  |       |                          |       |      |                      |         |
| Drive Level       | Pd               | 0.01  |                          | 500   | μW   |                      |         |
| Insulation        | IR               | 500   |                          |       | ΜΩ   | 100V(DC)             |         |
| Resistance        |                  |       |                          |       |      |                      |         |

#### 5. Measurement Condition

5.1 Frequency measurement

Measuring instrument : PI-Network Test Fixture

Load Capacitance :18.0pF Drive Level :10µW

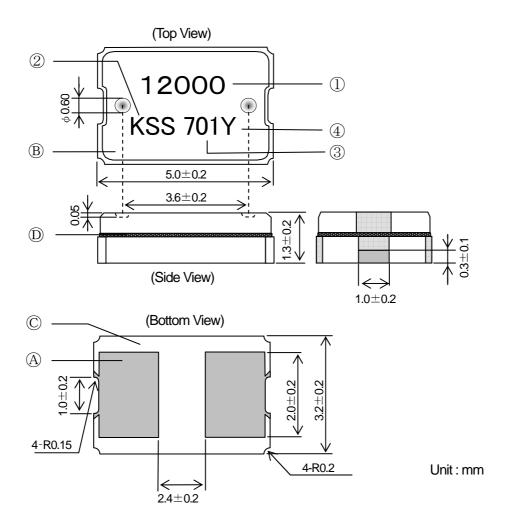
5.2 Equivalent series resistance (ESR) measurement

Measuring instrument : PI-Network Test Fixture

Load Capacitance : Series

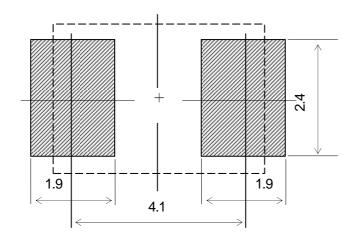
Drive Level : 10µW

# 6. APPEARANCES, PHYSICAL DIMENSION OUTLINE DIMENSION (not to scale)



|            | T                               |  |
|------------|---------------------------------|--|
| A          | Terminal                        | W-Ni-Au(Pb-Free)                               |
| B          | CAP                             | CERAMICS (BLACK)                               |
| ©          | BASE                            | CERAMICS (BLACK)                               |
| D          | GLASS                           | LOW TEMPERATURE GLASS                          |
|            |                                 |  |
|            | MARKING                         | NOTE   |
| 1          | NOMINAL FREQUENCY               | (5 DIGITS MAX) UNIT: kHz                       |
| 2          | IDENTIFICATION                  | _  |
| (3)        | DATE CODE                       | YEAR · · · · LAST 1 DIGIT of YEAR AND WEEK     |
|            | <i>5</i> /112 0052              | EXAMPLE $\cdots$ Jan. 1,2017 $\rightarrow$ 701 |
| <b>(4)</b> | MANUFACTURING                   | Y : Japan (Yamagata)                           |
|            | LOCATION                        | T : Thailand                                   |
| * The      | e font of marking is reference. |  |

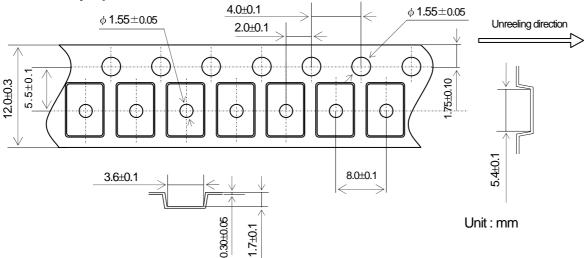
### 7. RECOMMENDED LAND PATTERN (not to scale)



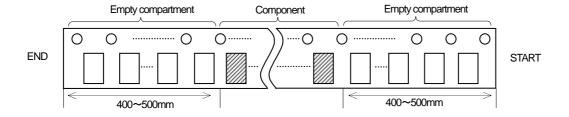
Unit: mm

#### 8. TAPING & REEL

#### 8.1 Carry tape dimension

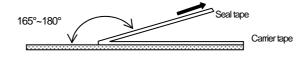


#### 8.2 Leader and trailer tape



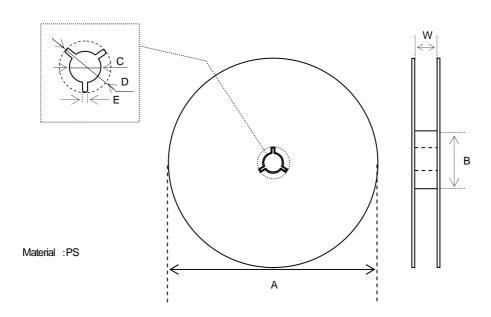
#### 8.3 Taping specification

- 1. Material of the carrier tape shall be A-PET or PS (ESD)
- 2. The seal tape shall not cover the sprocket holes. And not protrude from the carrier tape.
- 3. Tensile strength of the tape: 10N or more.
- 4. The number of lack is 0.1% of 1 reel total part number (the number of the table letters) or the part following whose 1 either is big. (But, the thing which lack of the continuance is not in.)
- 5. The R of the corner without designation is 0.3R MAX.
- 6. Misalignment between centers of the cavity and sprocket hole shall be 0.05mm or less.
- 7. Peeling force of the seal tape (Peeling speed 300mm/min.): 0.1 to 1.0N.
- 8. Cumulative pitch error of feed hole: 50 pitch→±0.3mm
- 9. The marking on parts is not fixed its direction, its electrical characteristic is equal.



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|-------------|-----------------------|-----|--|

#### 8.4 Reel specifications



#### $\phi$ 180 Reel (1,000 pcs. Max.)

| \$ 100 1 (00) (1)000 poor mostly |      |      |     |     |  |  |  |
|----------------------------------|------|------|-----|-----|--|--|--|
| Symbol                           | Α    | В    | С   | D   |  |  |  |
| Dimension                        | φ180 | φ60  | φ13 | φ21 |  |  |  |
| Symbol                           | E    | W    |     |     |  |  |  |
| Dimension                        | 2.0  | 13.0 |     |     |  |  |  |

(Unit:mm)

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|---------------------------------------|
|---------------------------------------|

#### 9.Enviromental requirements

(Reference: AEC-Q200 Rev. D. The solder used by examination is hereafter set to Sn-3Ag-0.5Cu.) After following test, Frequency applies to each item and CI,  $\pm 20\%$  or  $5\Omega$  of large value.

| No   | Stress                     | Reference     | Additional Requirements                                |
|------|----------------------------|---------------|--|
| 9.1  | High Temperature Exposure  | MIL-STD-202   | 1000 hrs. at rated operating temperature (e.g. 85°C    |
|      | (Storage)                  | Method 108    | part can be stored for 1000 hrs at 85°C. Same applies  |
|      |                            |               | for 125°C). Unpowered.                                 |
|      |                            |               | Measurement at 24±4 hours after test conclusion.       |
| 9.2  | Temperature Cycling        | JESD22        | 1000 cycles (-40°C to 125°C) Note: If 85°C part the    |
|      |                            | Method JA-104 | 1000 cycles will be at that temperature rating.        |
|      |                            |               | Measurement at 24±4 hours after test conclusion.       |
|      |                            |               | 30min maximum dwell time at each temperature           |
|      |                            |               | extreme. 1 min. maximum transition time.               |
| 9.3  | Biased Humidity            | MIL-STD- 202  | 1000 hours 85°C/85%RH. Rated VDD applied with 1        |
|      |                            | Method 103    | MW and inverter in parallel, 2X crystal CL capacitors  |
|      |                            |               | between each crystal leg and GND.                      |
|      |                            |               | Measurement at 24±4 hours after test conclusion.       |
| 9.4  | Operational Life           | MIL-STD- 202  | Note: 1000 hrs @ 125°C. If 85°C part will be tested at |
|      |                            | Method 108    | that temperature. Rated VDD applied with 1 MW and      |
|      |                            |               | inverter in parallel, 2X crystal CL capacitors between |
|      |                            |               | each crystal leg and GND.                              |
|      |                            |               | Measurement at 24±4 hours after test conclusion.       |
| 9.5  | Terminal Strength (Leaded) | MIL-STD- 202  | Test leaded device lead integrity only. Conditions: A  |
|      |                            | Method 211    | (227 g), C (227 g).                                    |
| 9.6  | Resistance to Solvents     | MIL-STD- 202  | Note: Also aqueous wash chemical - OKEM clean or       |
|      |                            | Method 215    | equivalent. Do not use banned solvents.                |
| 9.7  | Mechanical Shock           | MIL-STD-202   | Figure 1 of Method 213. Condition C                    |
|      |                            | Method 213    |  |
| 9.8  | Vibration                  | MIL-STD-202   | 5g's for 20 minutes 12 cycles each of 3 orientations.  |
|      |                            | Method 204    | Note: Use 8"X5" PCB .031" thick with 7 secure points   |
|      |                            |               | on one 8" side and 2 secure points on corners of       |
|      |                            |               | opposite sides. Parts mounted within 2" from any       |
|      |                            |               | secure point. Test from 10-2000 Hz.                    |
| 9.9  | Resistance to              | MIL-STD-202   | Condition B No pre-heat of samples. Note: Single       |
|      | Soldering Heat             | Method 210    | Wave solder - Procedure 1 with solder within 1.5 mm of |
|      |                            |               | device body for Leaded. Procedure 1 except 230°C       |
|      |                            |               | and immerse only to level to cover terminals for SMD.  |
| 9.10 | Solder ability             | J-STD-002     | For both Leaded & SMD. Electrical Test not required.   |
|      |                            |               | Magnification 50 X. Conditions:                        |
|      |                            |               | Leaded: Method A @ 235°C, category 3.                  |
|      |                            |               | SMD: a) Method B, 4 hrs @ 155°C dry heat @ 235°C       |
|      |                            |               | b) Method B @ 215°C category 3.                        |
| 0.44 | Flancous L T'              | 111.04        | c) Method D category 3 @ 260°C.                        |
| 9.11 | Flammability               | UL-94         | V-0 or V-1 Acceptable                                  |
| 9.12 | Board Flex                 | AEC Q200-005  | 60 sec minimum holding time.                           |
| 9.13 | Terminal Strength(SMD)     | AEC Q200-006  | -  |

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|-------------|-----------------------|-----|--|

#### 10. Cautions for use

(1) Soldering upon mounting

There is a possibility to influence product characteristics when Solder paste or conductive glue comes in contact with product lid or surface.

#### (2) When using mounting machine

Please minimize the shock when using mounting machine to avoid any excess stress to the product.

#### (3) Conformity of a circuit

We strongly recommend to make sure that Negative resistance (Gain) of IC is designed to be 10 times the ESR (Equivalent Series Resistance) of crystal unit.

(4) After making the Quartz Crystal mount on a printed circuit board, if it is required to devide the printed circuit board into another one, use it with attentive confirmation so that a warp cased by this dividing might not affect any damage. When designing a printed circuit board as well as handling the mounting As much as possible. The quartz crystal shall be passed through the reflow furnace. Then it shall be subjected to standard atmospheric conditions, after which cleaning shall be made.

#### 11. Storage conditions

Please store product in below conditions, and use within 6 months.

Temperature +18 to +30°C, and Humidity of 20 to 70 % in the packaging condition.

#### 12. Manufacturing location

Kyocera Crystal Device Corporation / Japan(Yamagata)

Kyocera Crystal Device (Thailand) Co., Ltd / Thailand(Lamphun)

#### 13. Quality Assurance

Kyocera Crystal Device Quality Assurance Division

#### 14. Quality guarantee

In case when Kyocera Crystal Device Corporation rooted failure occurred within 1 year after its delivery, substitute product will be arranged based on discussion. Quality guarantee of product after 1 year of its delivery is waivered.

#### 15.Others

In case of any questions or opinions regarding the Specification, please have it in written manner within 45 days after issued date.

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